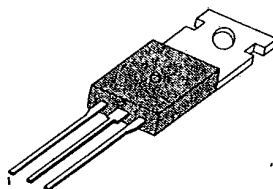


MJE3055T**NPN SILICON TRANSISTOR**
**GENERAL PURPOSE AND SWITCHING
APPLICATIONS
DC CURRENT GAIN SPECIFIED
TO 10 AMPERES**
High Current Gain-Bandwidth Product ($f_T = 2\text{MHz (MIN)}$)**ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)**

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V_{CB0}	70	V
Collector-Emitter Voltage	V_{CE0}	60	V
Emitter-Base Voltage	V_{EB0}	5	V
Collector Current	I_C	10	A
Base Current	I_B	6	A
Collector Dissipation ($T_c = 25^\circ\text{C}$)	P_C	75	W
Collector Dissipation ($T_a = 25^\circ\text{C}$)	P_C	0.6	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	$-55 \sim 150$	$^\circ\text{C}$

TO-220



1. Base 2. Collector 3. Emitter

3

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Emitter Sustaining Voltage	$V_{CE0(sus)}$	$I_C = 200\text{mA}, I_B = 0$	60		V
Collector Cutoff Current	I_{CE0}	$V_{CE} = 30\text{V}, I_B = 0$		700	μA
Collector Cutoff Current	I_{CEX}	$V_{CE} = 70\text{V}, V_{BE(off)} = -1.5\text{V}$ $V_{CE} = 70\text{V}, V_{BE(off)} = -1.5\text{V}$ $T_c = 150^\circ\text{C}$		1 5	μA mA
Emitter Cutoff Current	I_{EB0}	$V_{EB} = 5\text{V}, I_C = 0$		5	mA
*DC Current Gain	h_{FE}	$V_{CE} = 4\text{V}, I_C = 4\text{A}$ $V_{CE} = 4\text{V}, I_C = 10\text{A}$	20 5	100	
*Collector Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C = 4\text{A}, I_B = 0.4\text{A}$ $I_C = 10\text{A}, I_B = 3.3\text{A}$		1.1 8	V V
*Base Emitter On Voltage	$V_{BE(on)}$	$V_{CE} = 4\text{V}, I_C = 4\text{A}$		1.8	V
Current Gain Bandwidth Product	f_T	$V_{CE} = 10\text{V}, I_C = 500\text{mA}, f = 500\text{KHz}$	2		MHz

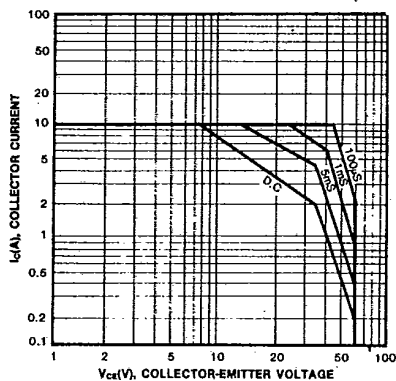
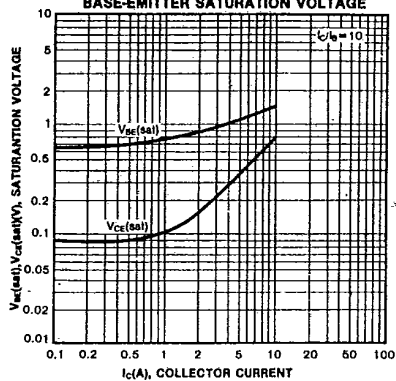
* Pulse test: $PW \leq 300\mu\text{s}$, duty cycle $\leq 2\%$ Pulse

MJE3055T

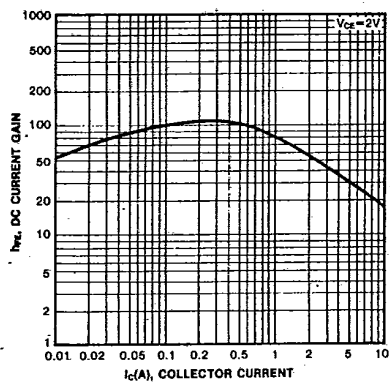
NPN SILICON TRANSISTOR

T-33-13

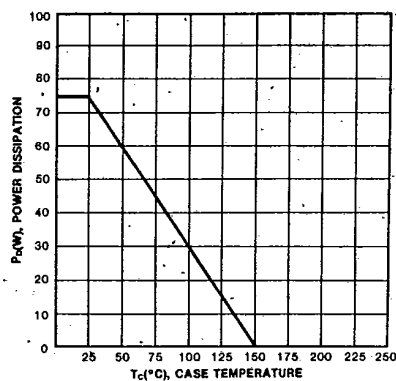
SAFE OPERATING AREA

COLLECTOR-EMITTER SATURATION VOLTAGE
BASE-EMITTER SATURATION VOLTAGE

DC CURRENT GAIN



POWER DERATING



TIP29 SERIES

(TIP29/29A/29B/29C) NPN EXITAXIAL SILICON TRANSISTOR

SAMSUNG SEMICONDUCTOR INC

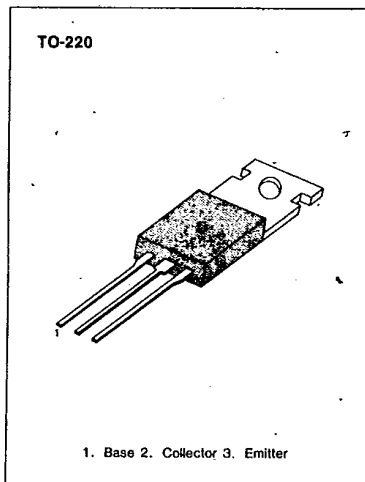
T-33-09

**MEDIUM POWER LINEAR
SWITCHING APPLICATIONS**

• Complementary to TIP30/30A/30B/30C

ABSOLUTE MAXIMUM RATINGS ($T_a=25^{\circ}\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : TIP29	V_{CBO}	40	V
: TIP29A		60	V
: TIP29B		80	V
: TIP29C		100	V
Collector-Emitter Voltage : TIP29	V_{CEO}	40	V
: TIP29A		60	V
: TIP29B		80	V
: TIP29C		100	V
Emitter-Base Voltage	V_{EBO}	5	V
Collector Current (DC)	I_C	1	A
Collector Current (Pulse)	I_C	3	A
Base Current	I_B	0.4	A
Collector Dissipation ($T_c=25^{\circ}\text{C}$)	P_C	30	W
Collector Dissipation ($T_a=25^{\circ}\text{C}$)	P_C	2	W
Junction Temperature	T_J	150	$^{\circ}\text{C}$
Storage Temperature	T_{stg}	-65~150	$^{\circ}\text{C}$



3

ELECTRICAL CHARACTERISTICS ($T_c=25^{\circ}\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
*Collector Emitter Sustaining Voltage : TIP29	BV_{CEO} (sus)	$I_C=30\text{mA}, I_B=0$	40		V
: TIP29A			60		V
: TIP29B			80		V
: TIP29C			100		V
Collector Cutoff Current : TIP29/29A	I_{CEO}	$V_{CE}=30\text{V}, I_B=0$		0.3	mA
: TIP29B/29C		$V_{CE}=60\text{V}, I_B=0$		0.3	mA
Collector Cutoff Current : TIP29	I_{CES}	$V_{CE}=40\text{V}, V_{EB}=0$		200	μA
: TIP29A		$V_{CE}=60\text{V}, V_{EB}=0$		200	μA
: TIP29B		$V_{CE}=80\text{V}, V_{EB}=0$		200	μA
: TIP29C		$V_{CE}=100\text{V}, V_{EB}=0$		200	μA
Emitter Cutoff Current	I_{EBO}	$V_{BE}=5\text{V}, I_C=0$		1.0	mA
*DC Current Gain	h_{FE}	$V_{CE}=4\text{V}, I_C=0.2\text{A}$	40		
		$V_{CE}=4\text{V}, I_C=1\text{A}$	15	75	
*Collector-Emitter Saturation Voltage	$V_{CE}(\text{sat})$	$I_C=1\text{A}, I_B=125\text{mA}$		0.7	V
*Base-Emitter On Voltage	$V_{BE}(\text{on})$	$V_{CE}=4\text{V}, I_C=1\text{A}$		1.3	V
Current Gain Bandwidth Product	f_T	$V_{CE}=10\text{V}, I_C=200\text{mA}$ $f=1\text{MHz}$	3.0		MHz

* Pulse Test: $PW \leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$

TIP29 SERIES

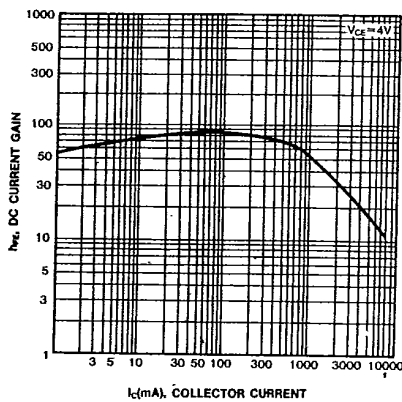
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(TIP29/29A/29B/29C) NPN EXITAXIAL SILICON TRANSISTOR

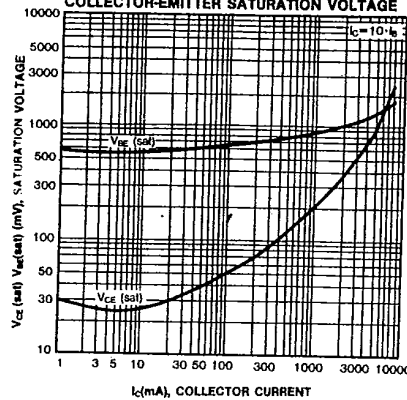
SAMSUNG SEMICONDUCTOR INC

T-33-09

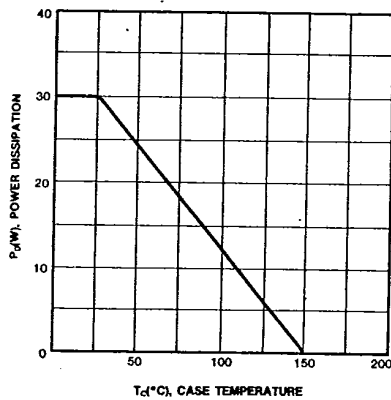
DC CURRENT GAIN



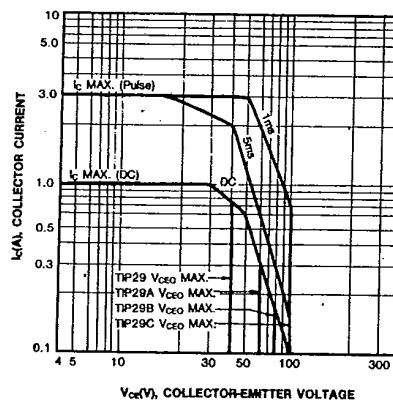
BASE-EMITTER SATURATION VOLTAGE
COLLECTOR-EMITTER SATURATION VOLTAGE



POWER DERATING



SAFE OPERATING AREA



SAMSUNG SEMICONDUCTOR

TIP30 SERIES**(TIP30/30A/30B/30C) PNP EXITAXIAL SILICON TRANSISTOR**

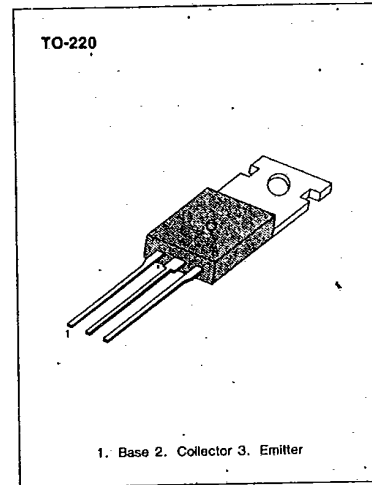
T-33-19

**MEDIUM POWER LINEAR
SWITCHING APPLICATIONS**

- Complement to TIP29/29A/29B/29C

ABSOLUTE MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage : TIP30	V_{CB0}	-40	V
: TIP30A		-60	V
: TIP30B		-80	V
: TIP30C		-100	V
Collector-Emitter Voltage : TIP30		-40	V
: TIP30A	V_{CE0}	-60	V
: TIP30B		-80	V
: TIP30C		-100	V
Emitter-Base Voltage	V_{EB0}	-5	V
Collector Current (DC)	I_C	-1	A
Collector Current (Pulse)	I_C	-3	A
Base Current	I_B	-0.4	A
Collector Dissipation ($T_c = 25^\circ\text{C}$)	P_C	30	W
Collector Dissipation ($T_a = 25^\circ\text{C}$)	P_C	2	W
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature	T_{stg}	-65~150	$^\circ\text{C}$



3

ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$)

Characteristic	Symbol	Test Condition	Min	Max	Unit
* Collector Emitter Sustaining Voltage : TIP30	$BV_{CE0} \text{ (SUS)}$	$I_C = -30\text{mA}, I_B = 0$	-40		V
: TIP30A			-60		V
: TIP30B			-80		V
: TIP30C			-100		V
Collector Cutoff Current : TIP30/30A	I_{CE0}	$V_{CE} = -30\text{V}, I_B = 0$		-0.3	mA
: TIP30B/30C		$V_{CE} = -60\text{V}, I_B = 0$		-0.3	mA
Collector Cutoff Current : TIP30	I_{CES}	$V_{CE} = -40\text{V}, V_{EB} = 0$		-200	μA
: TIP30A		$V_{CE} = -60\text{V}, V_{EB} = 0$		-200	μA
: TIP30B		$V_{CE} = -80\text{V}, V_{EB} = 0$		-200	μA
: TIP30C		$V_{CE} = -100\text{V}, V_{EB} = 0$		-200	μA
Emitter Cutoff Current	I_{EBO}	$V_{BE} = -5\text{V}, I_C = 0$		-1.0	mA
* DC Current Gain	β_{FE}	$V_{CE} = -4\text{V}, I_C = -0.2\text{A}$	40		
		$V_{CE} = -4\text{V}, I_C = -1\text{A}$	15	75	
* Collector-Emitter Saturation Voltage	$V_{CE} \text{ (sat)}$	$I_C = -1\text{A}, I_B = -125\text{mA}$		-0.7	V
* Base-Emitter On Voltage	$V_{BE} \text{ (on)}$	$V_{CE} = -4\text{V}, I_C = -1\text{A}$		-1.3	V
Current Gain Bandwidth Product	f_T	$V_{CE} = -10\text{V}, I_C = -200\text{mA}$ $f = 1\text{MHz}$	3.0		MHz

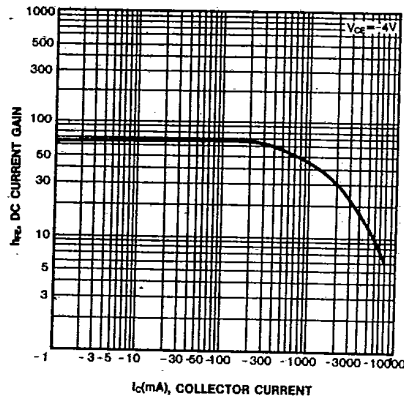
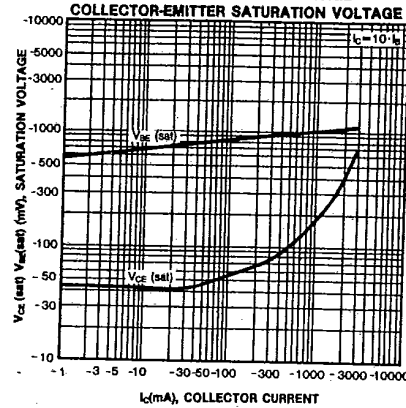
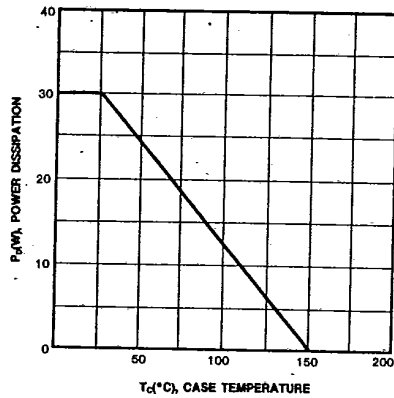
* Pulse Test: $PW \leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$



SAMSUNG SEMICONDUCTOR

TIP30 SERIES**(TIP30/30A/30B/30C) PNP EXITAXIAL SILICON TRANSISTOR**

T-33-19

DC CURRENT GAIN**BASE-EMITTER SATURATION VOLTAGE****POWER DERATING****SAFE OPERATING AREA**